Notice of References Cited Application/Control No. 6693021 Examiner Savitri Mulpuri Applicant(s)/Patent Under Reexamination ISHIBASHI ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0152952	10-2002	Beaumont et al.	117/95
*	В	US-6,693,021	02-2004	Motoki et al.	438/481
*	С	US-2002/0046693	04-2002	Kiyoku et al.	117/8
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO99/20816	04-1999	france	beaumont	
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	A twostp method for epitaxial lateral overgrowth of GaN(see conference article presented by Meaumont July 1999.3 rd internation conference on Nitride semiconductors Montpellier, france 4-9 July 1999.
	V	
	w	
	x	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.